

***Noise coupling  
due to scattered light  
from output optics***

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# ***Contents of the talk***

- Brief introduction of simulation activities in TAMA/LCGT collaborations

- Scattered light noise

**Motivation**

**Principle of the noise**

**Approach used in this study**

**Simulation and interpretation of the result**

**Michelson/Recycled MI/Recycled FPMI**

**Discussion/Conclusion**

# ***Simulation activities in TAMA/LCGT***

- No comprehensive work to construct our own simulation environment / tool

- As users of the simulation softwares

**E2E:** (ICRR - Hayakawa, et al, with LIGO E2E team)

Modeling of CLIO (100-m cryogenic prototype in Kamioka)

$h(t)$  injection module

**Finesse:**

(NAOJ - Kawamura, et al

Lock acquisition study for Caltech 40m with LIGO 40m team)

Sensing design for an RSE interferometer (NAOJ - Kokeyama, et al)

Scattered light noise estimation (NAOJ - Arai, et al)

**LISO:**

Linear circuit simulations (NAOJ, U-Tokyo. etc)

- Analysis related simulations

**Software signal injection of galactic GW events**

**Crosstalk study of two co-located interferometer**

(Osaka City Univ - Kanda, et al)

# ***Scattered light ~ introduction***

- Demand of simulations from the site

## **Commissioning work**

- > Various kind of problems day by day
- > Always confused by the complicated “real world”

## **To grasp what is happening in the real detector**

- > Even a simple model is often sufficient
  - if it reflects the physics we want.
- > No need to be too exact
  - actual values will be obtained from experiments

## **Feedback to experiments**

- > Suggestions to the experiment
- > Suggestions of experimental methods

# Scattered light ~ motivation

- Scattered light noise

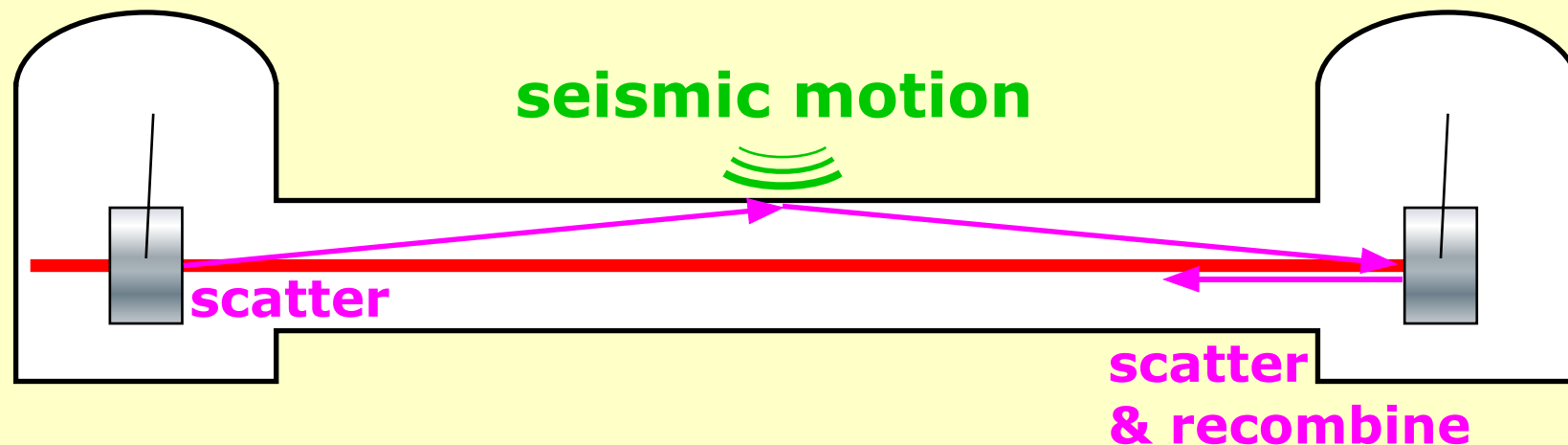
A) Scattered light in the beam tube

B) Scattered light at the optical ports

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A) Scattered light in the beam tube

> For the design of the long vacuum tubes and the baffles



> Experiment in TAMA

Excitation of a tube resonance:  $5.6\mu\text{m}@ 776.5\text{Hz} \Rightarrow 1 \times 10^{-17} \text{ m}$  in the sensitivity  
i.e. Seismic motion  $dx = \frac{1 \times 10^{-7}}{f^2} \text{ m/sqrtHz} \Rightarrow \sim \frac{2 \times 10^{-19}}{f^2} \text{ m/sqrtHz}$

**=> Negligible**

# Scattered light ~ motivation

## B) Scattered light at the optical ports

**Fact:** touching of the output optics  
=> mechanical peaks in the sensitivity

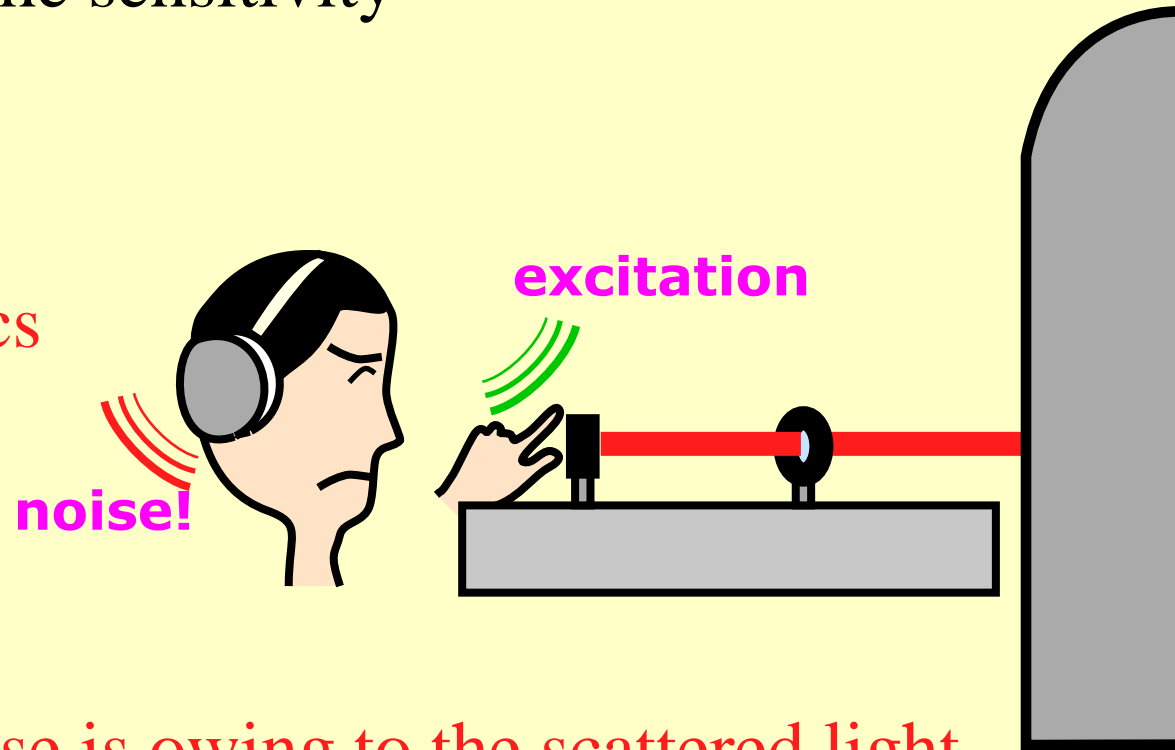
e.g.

> Tapping of the dark port optics

=> huge noise

> Bright port

=> moderate noise



Expect some fraction of the noise is owing to the scattered light

Q. Which optical port is dangerous? How much?

> Tapping every optics

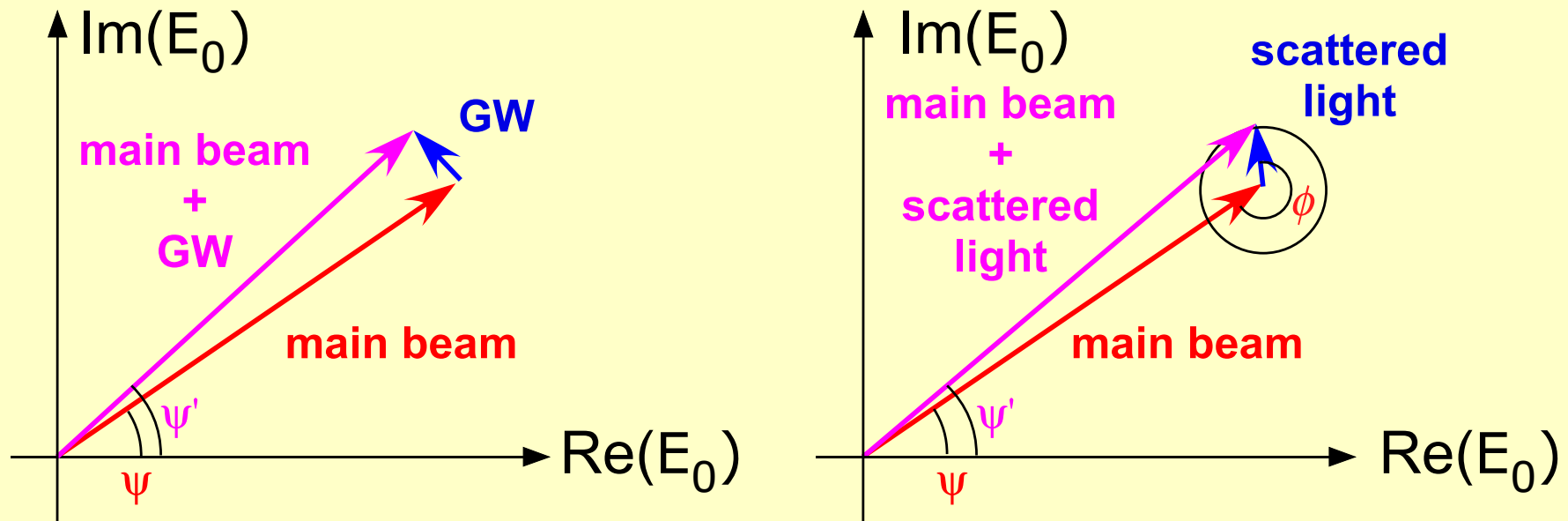
> More systematic estimation?

# Scattered light $\sim$ principle

- Coupling of scattered light to the output signal

**GW detector = optical phase sensor**

Electric field of the main beam  $E = E_0 e^{i \Omega t}$



Scattered light recombined to the main beam

Motion of the scattering body

=> perturbation of the optical phase

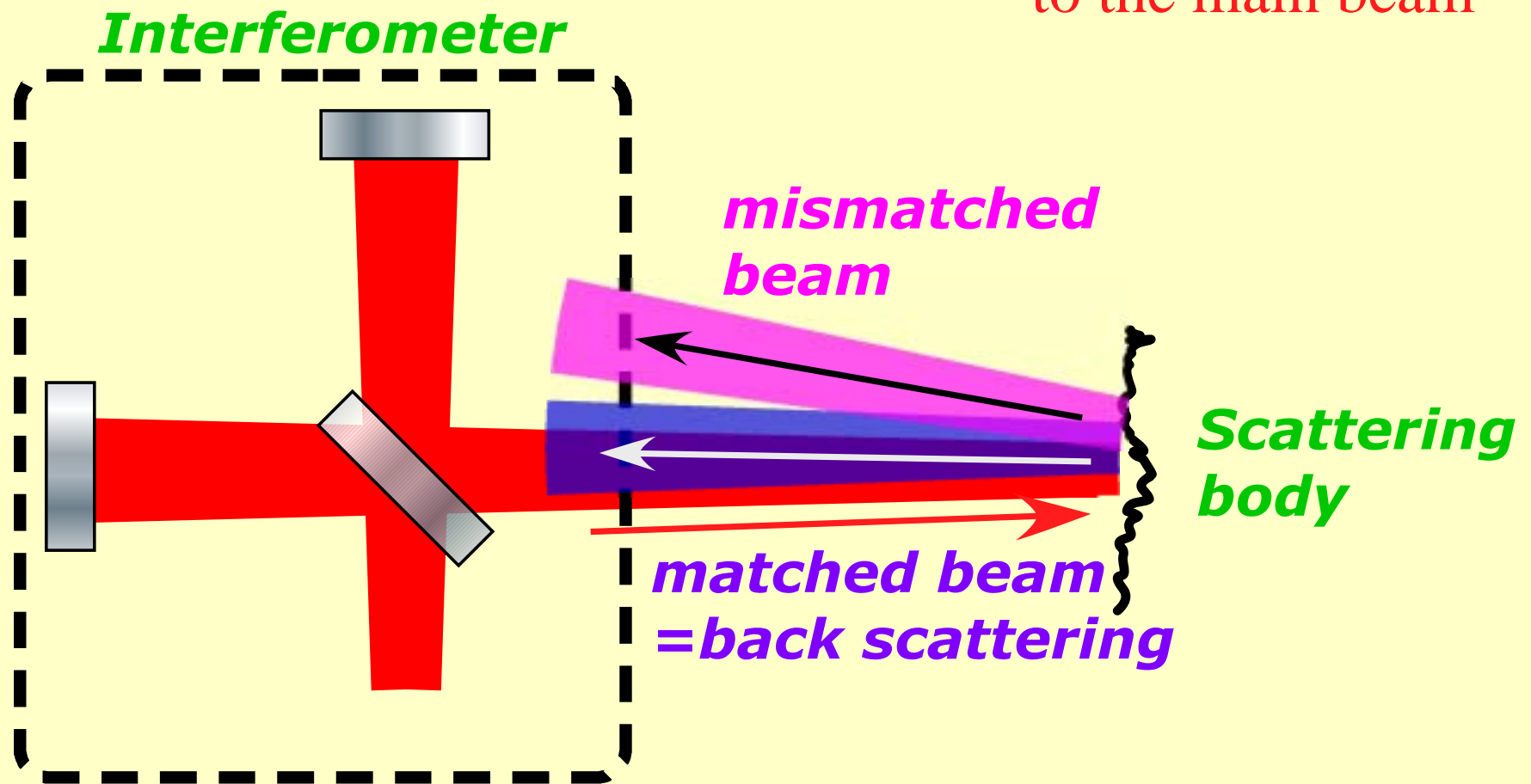
**=> Appear in the output signal**

# ***Scattered light ~ back scattering***

- Only back scattering is considered

**In order to couple to the output signal**

=> The scattered light should be spatially matched  
to the main beam

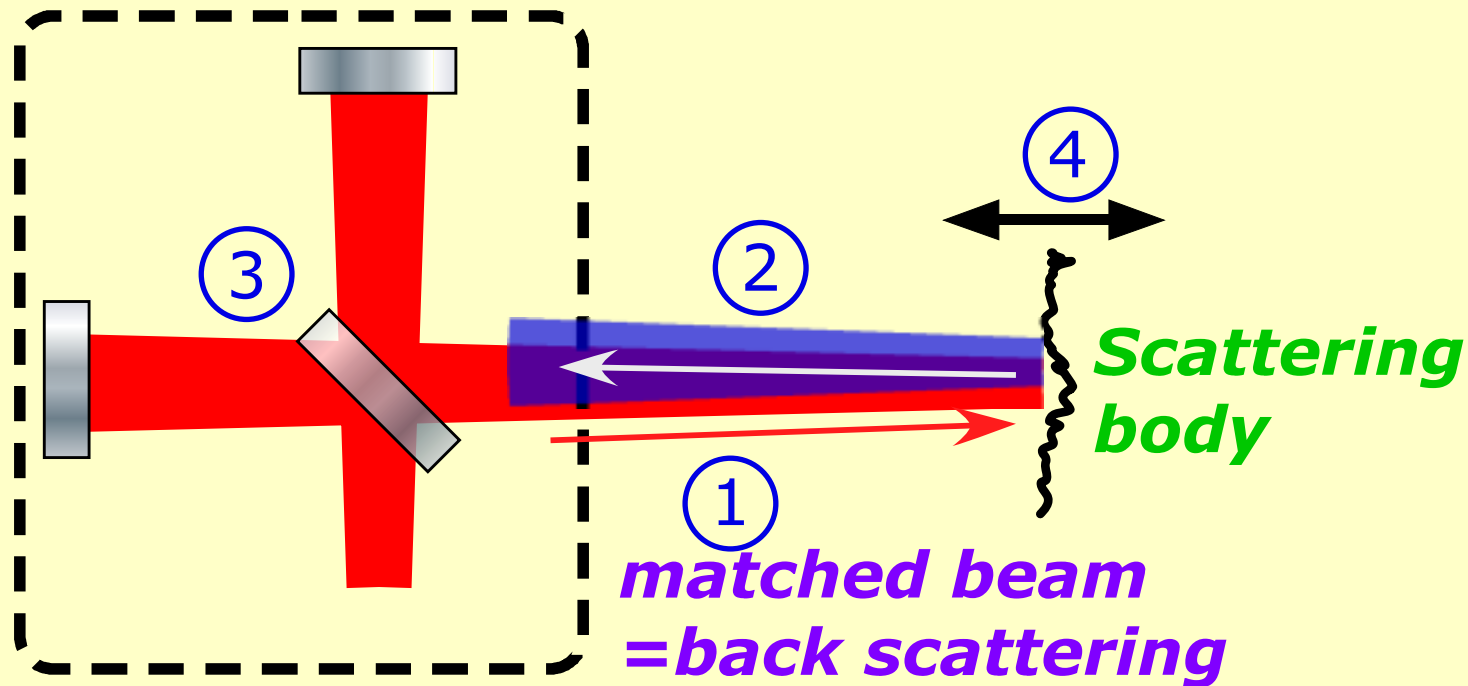


**=> Only consideration of TEM<sub>00</sub> is enough**

# Scattered light $\sim$ factors

- Factors to determine the amount of the noise

## Interferometer



1. Amount of the light power arrives  
on the scattering body.
2. Efficiency of effective back scattering
3. Sensitivity of the signal to the scattering
4. Amount of the scattering body's motion

$$P_{\text{out}}$$

$$\eta_{\text{scat}}$$

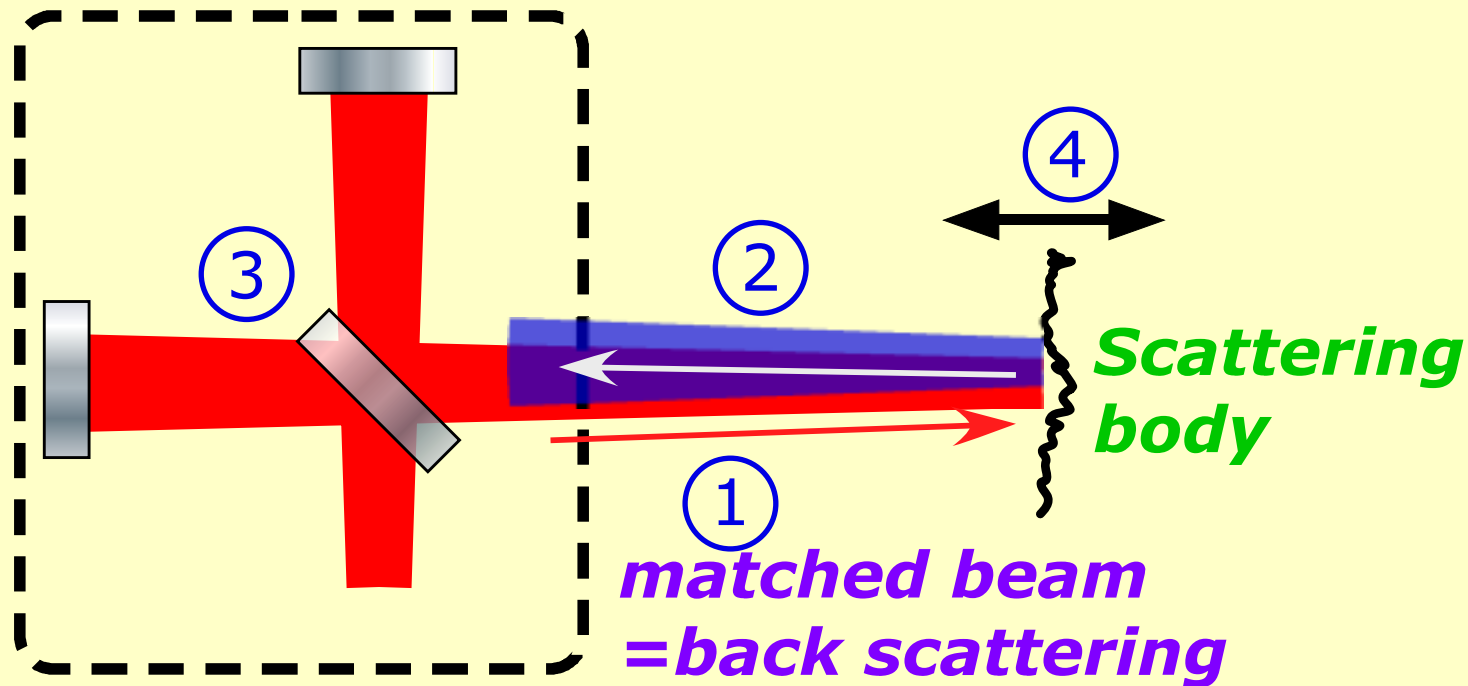
$$\alpha$$

$$\delta x_{\text{scat}}$$

# *Scattered light ~ factors*

- Factors to determine the amount of the noise

## *Interferometer*



1. Amount of the light power arrives on the scattering body. => **Easy to simulate**
2. Efficiency of effective back scattering => **Experiment**
3. Sensitivity of the signal to the scattering => **Easy to simulate**
4. Amount of the scattering body's motion => **Experiment**

# ***Simulation ~ Using Finesse***

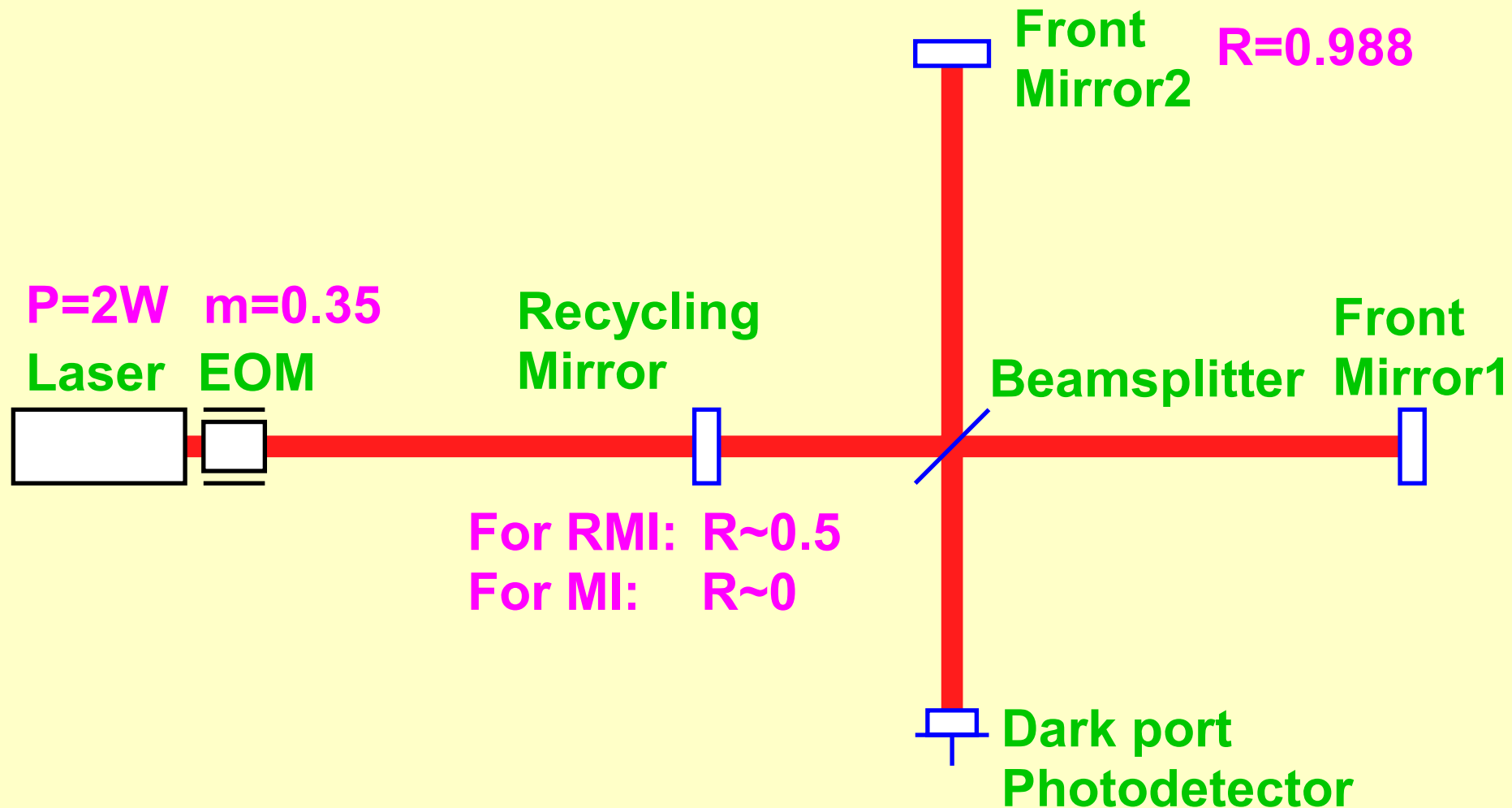
- "Finesse" is selected for the tool  
**Reason:** It looked the easiest tool for the purpose  
Any kind of length sensing tool does fit
- Use Finesse at the most basic level  
**Modulation sideband:** up to 1st order  
**Spatial mode:** only TEM<sub>00</sub>  
**Frequency range:** only at DC
- Based on the TAMA300 parameters  
**Michelson (MI) / Recycled Michelson (RMI) model**  
=> To understand nature of the scattered light noise  
  
**Recycled Fabry-Perot Michelson (RFPMI) model**  
=> To acquire the applicable knowledge to TAMA300

# *Simulation ~ MI/RMI model*

**RMI:**

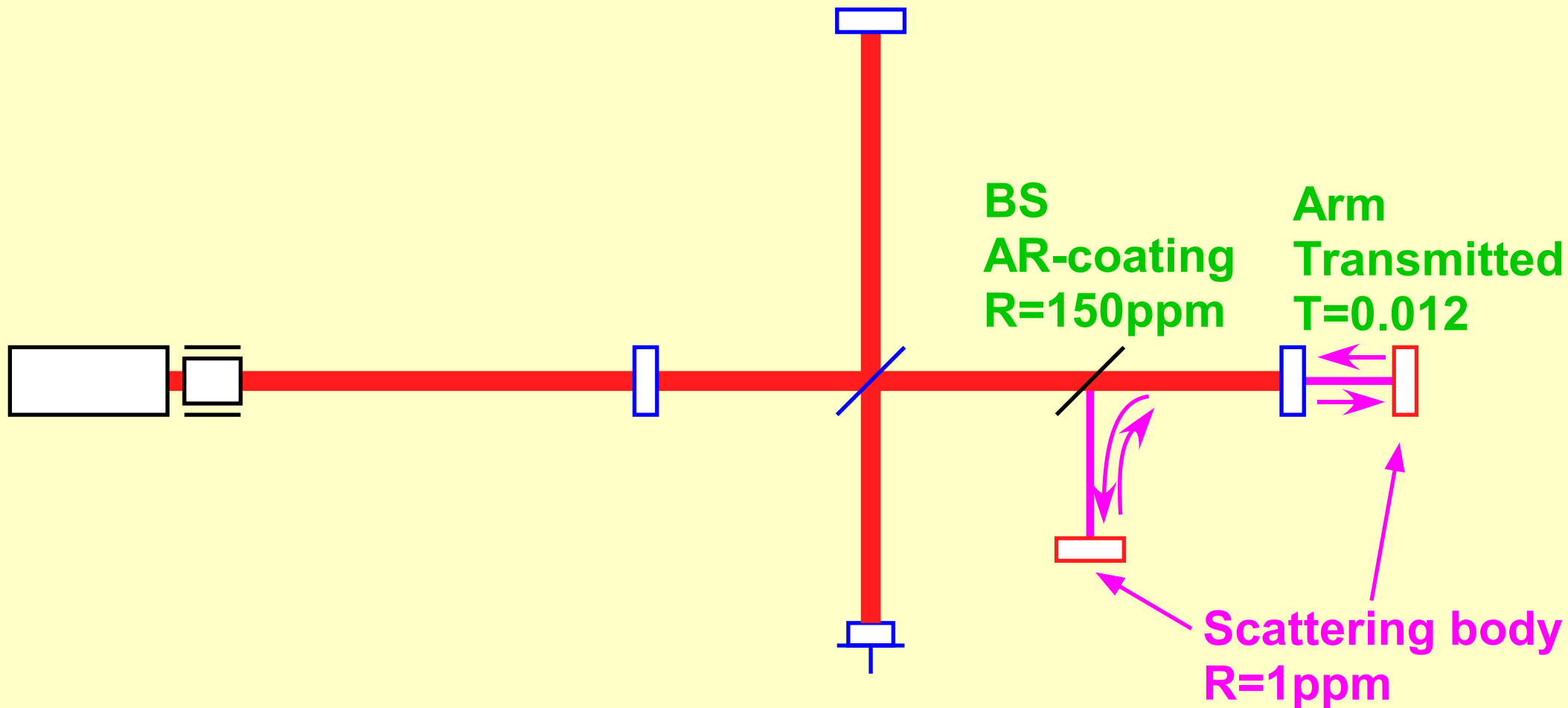
**The carrier is resonant**

**The sidebands are not resonant**



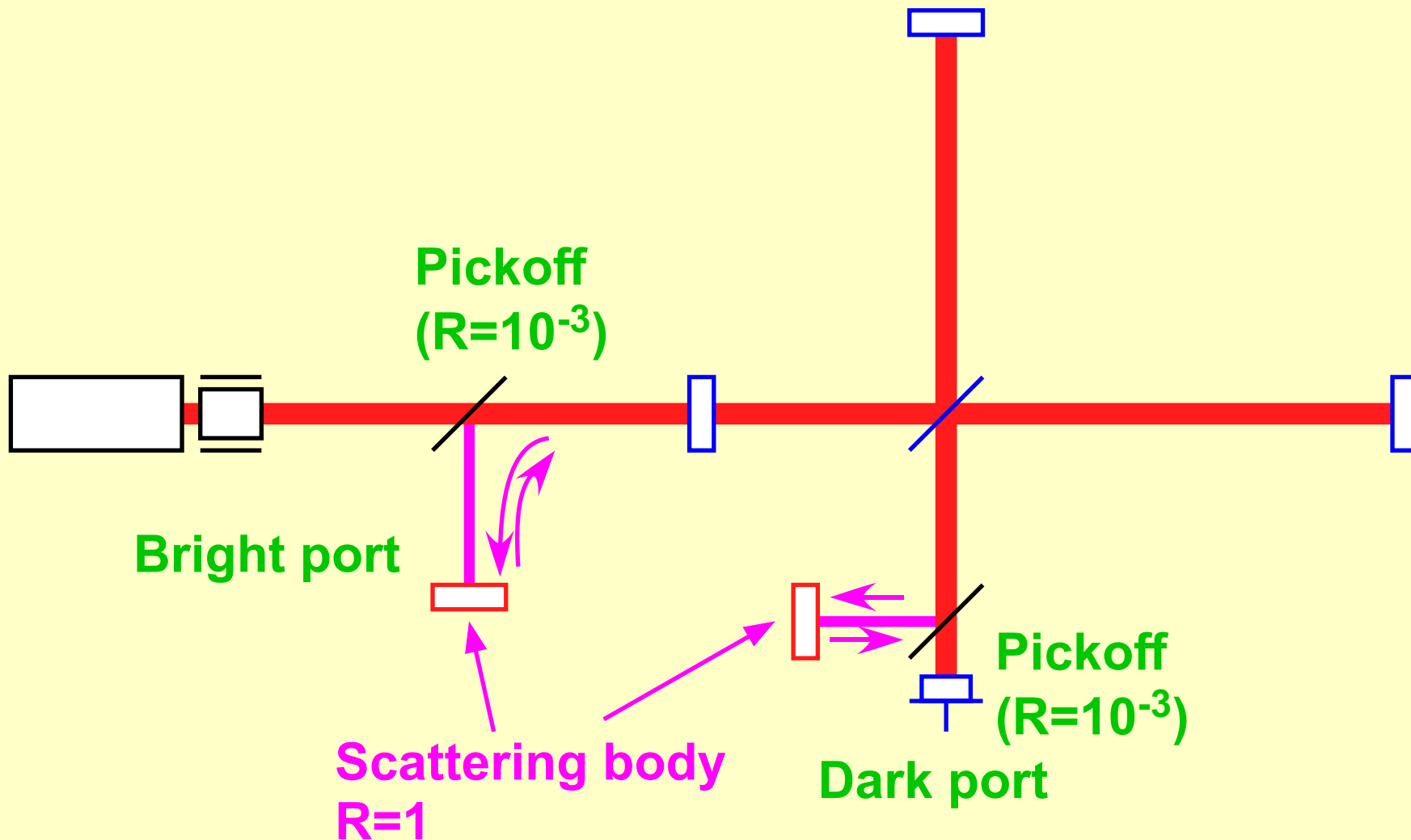
# *Simulation ~ MI/RMI model*

Placing scattering bodies  
with effective reflectivity of 1ppm



# ***Simulation $\sim$ MI/RMI model***

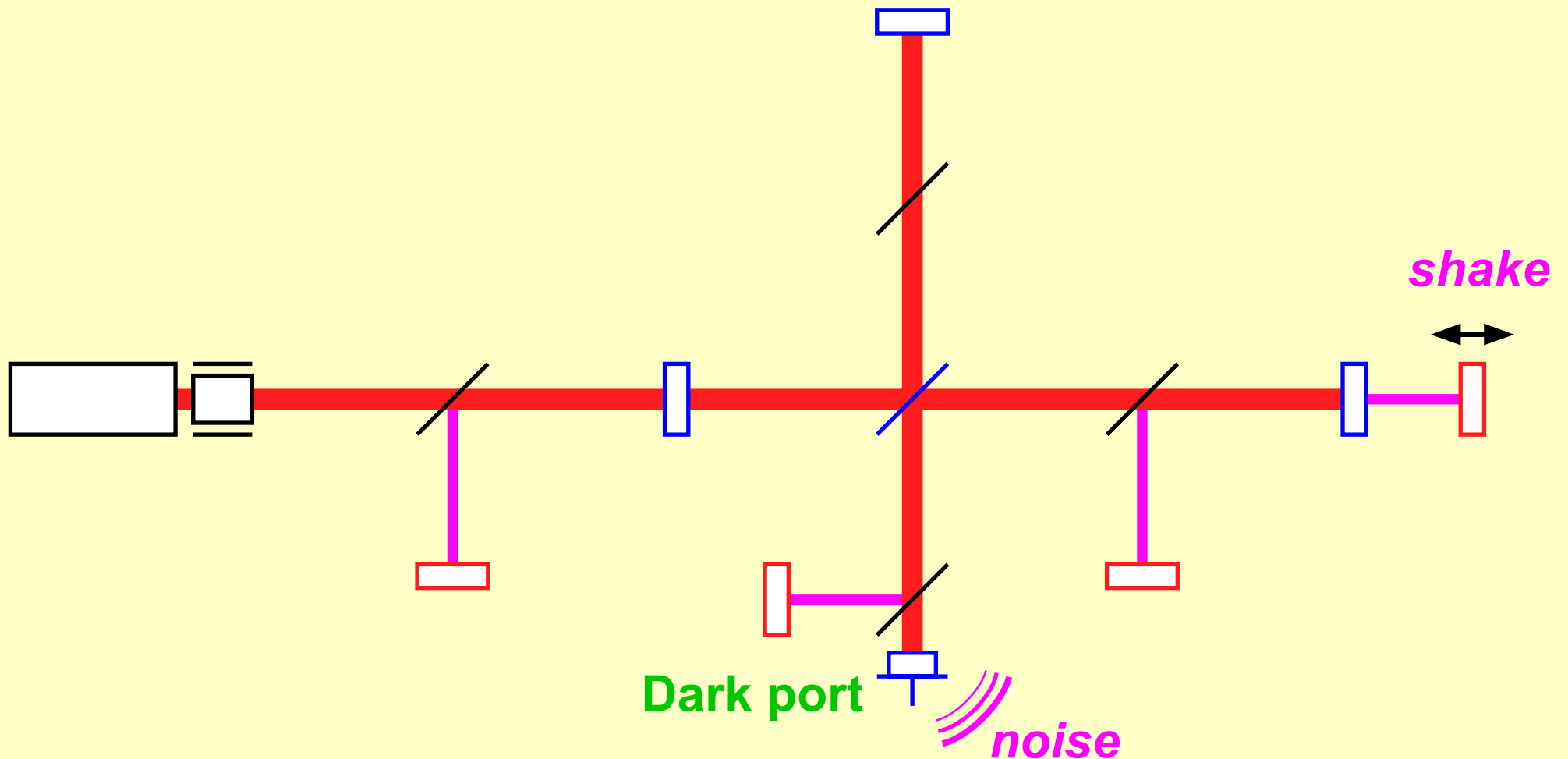
**Pickoff mirrors ( $R=10^{-3}$ ) are inserted at several places**  
 $\sim$  avoiding to disturb the internal condition



# ***Simulation $\sim$ MI/RMI model***

**Sweep the position of each scattering body**

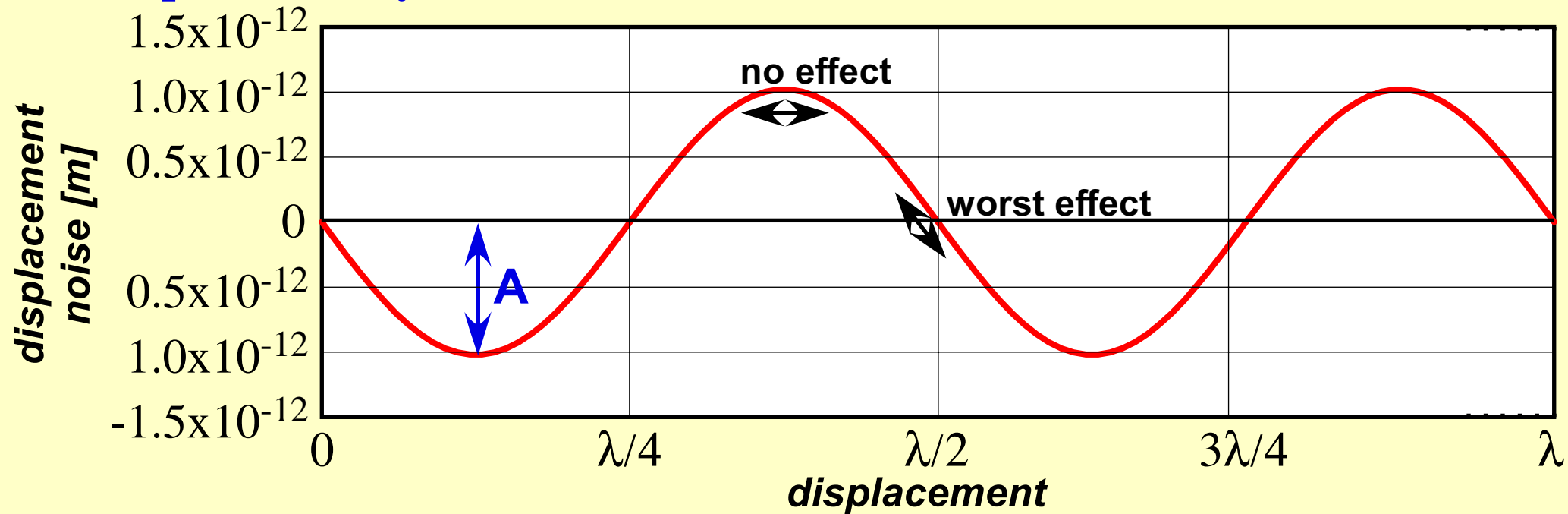
$\Rightarrow$  Look at the dark port signal



# ***Simulation ~ how to evaluate the result***

## ● Effect of the motion of the scattering source

**Example: noise by the motion of the mirror behind the arm**



> **Small amplitude motion**

$$\delta x_{\max} = (4 \pi A / \lambda) \delta x_{\text{scat}}$$

> **Large amplitude motion**

$$dx = A \quad \text{at } f = 2 \nu_{\text{scat}} / \lambda \quad (\text{fringe frequency})$$

> **Note:** Noise amplitude A is proportional

to the “amplitude” of the scattered light

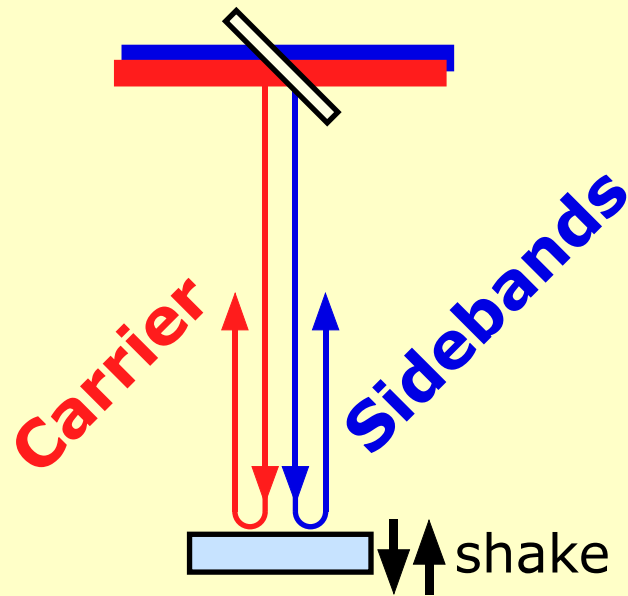
$$R_{\text{scat}} = 1 \text{ ppm} \Rightarrow A$$

$$R_{\text{scat}} = 100 \text{ ppm} \Rightarrow A' = 10 A$$

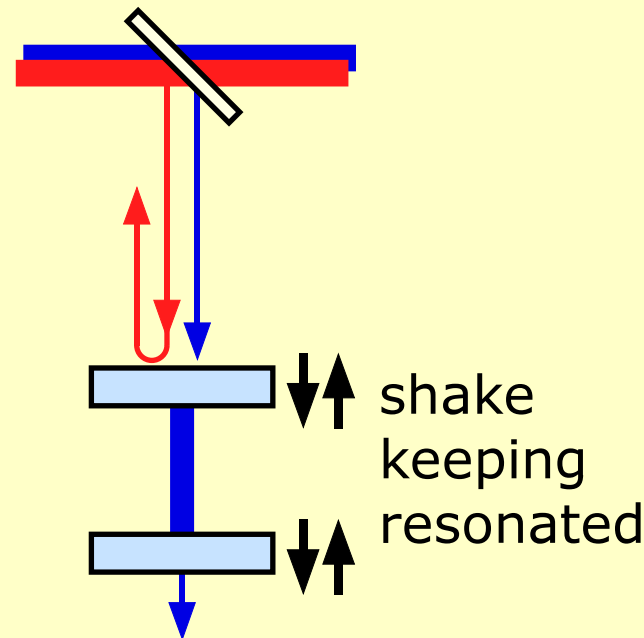
# ***Simulation ~ Carrier/sideband decomposition***

## ● Scattering source ~ three kinds of “mirrors”

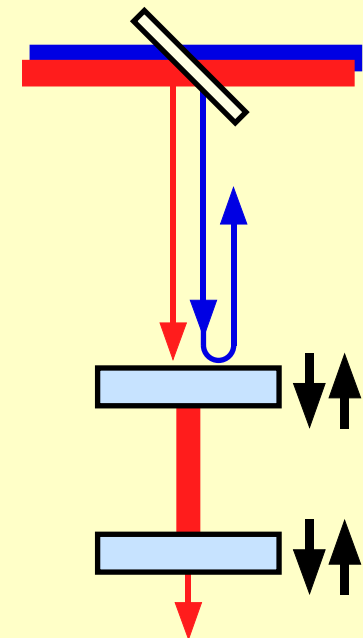
> Separating the contribution of  
the carrier and the modulation sidebands



Mirror:  
CA reflected  
SB reflected



SB resonant FP:  
CA reflected  
SB absorbed



CA resonant FP:  
CA absorbed  
SB reflected

(reflection 99.7%, absorption ~100%)

# ***Simulation method summary***

- Sweep the position of each scattering source  
**Scattering source at:** Arm trans., BS AR coat, Dark, Bright  
**Detector output:** Sin wave (amplitude  $A$ )  
 $\Rightarrow A = (P_{\text{out}})^{\varepsilon} \propto \eta_{\text{scat}}$  for  $\eta_{\text{scat}} = 1$  ppm
- Decompose the contribution of CA/SB  
**Ordinary mirror:** Carrier + Sidebands  
**SB resonant FP:** only Carrier  
**CA resonant FP:** only Sidebands
- Inject imperfections of the interferometer  
**Michelson offset:**  $dx = 10^{-12} \text{ m} \sim 10^{-10} \text{ m}$   
**Reflectivity mismatch of the arm mirrors:**  
 $dR = 100 \text{ ppm} \sim 10000 \text{ ppm}$   
**Note:** Macro- and microscopic deviations of the recycling cavity hardly effect the results

# ***MI/RMI model ~ DC power***

## **RMI case:**

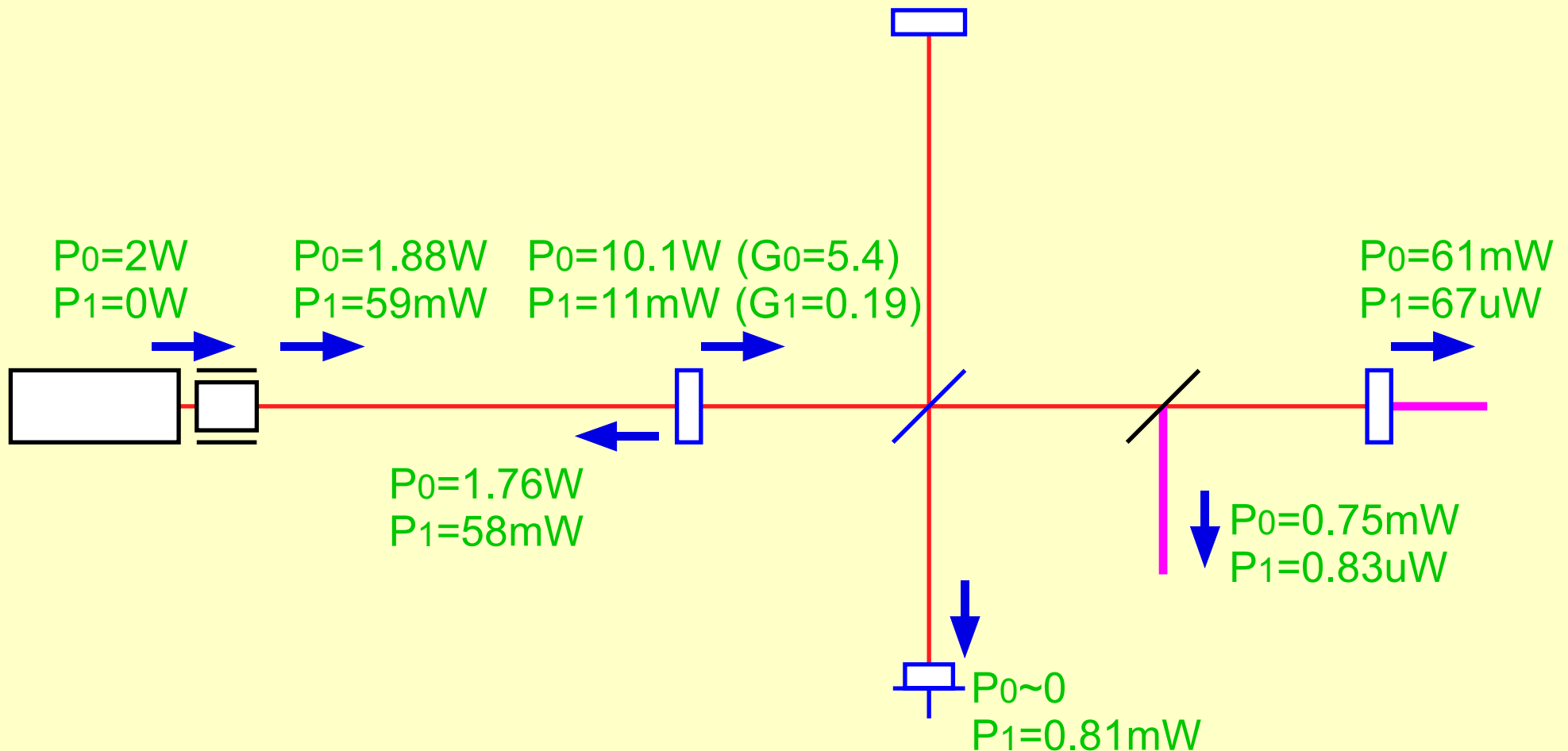
P0: carrier power

P1: sideband power

Power consumption:

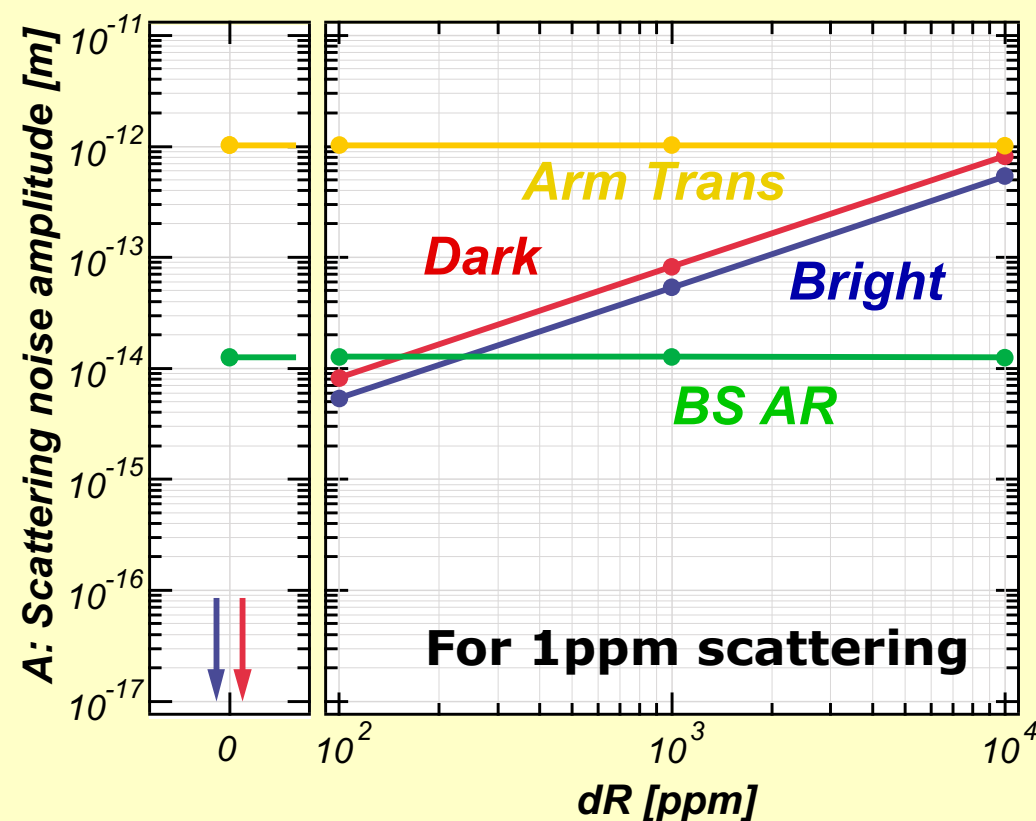
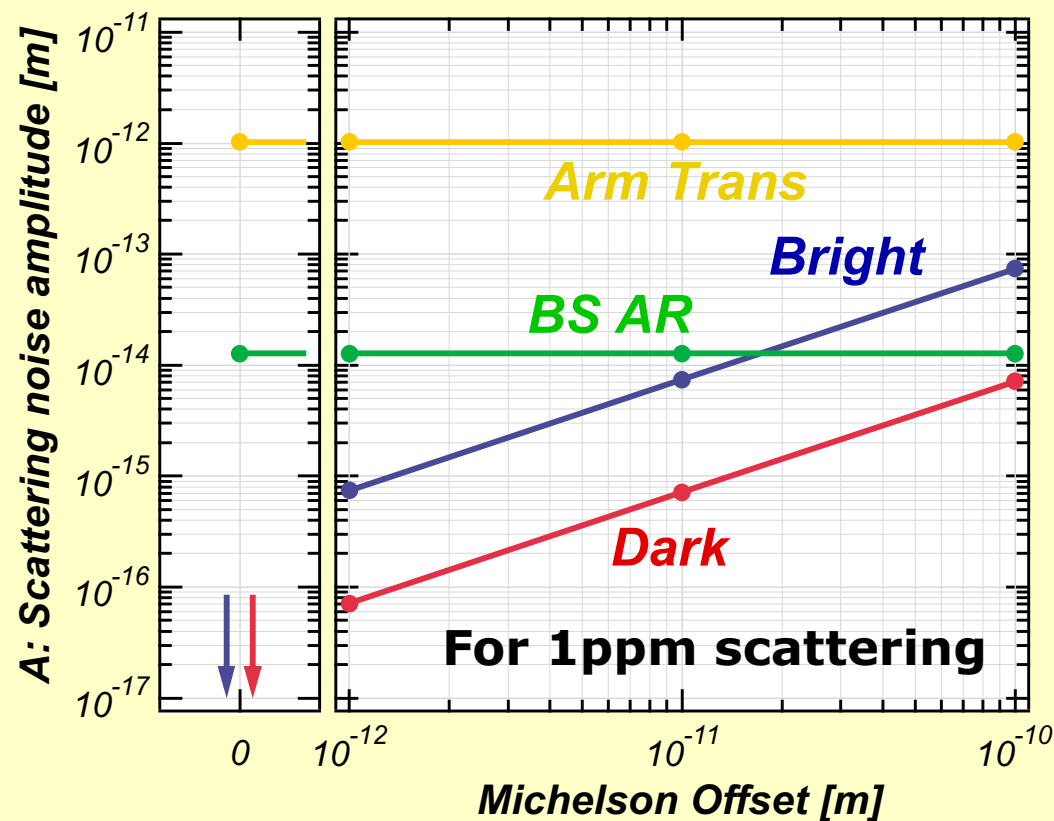
94% is reflected to the bright port

60mWx2 (3%x2) transmitted from the arms



**MI case: Change RM with  $R=0$**

# MI model ~ Result



**Arm trans. / BS AR noise level: not affected by the deviations**

Carrier added to only one of the arm => becomes the signal directly

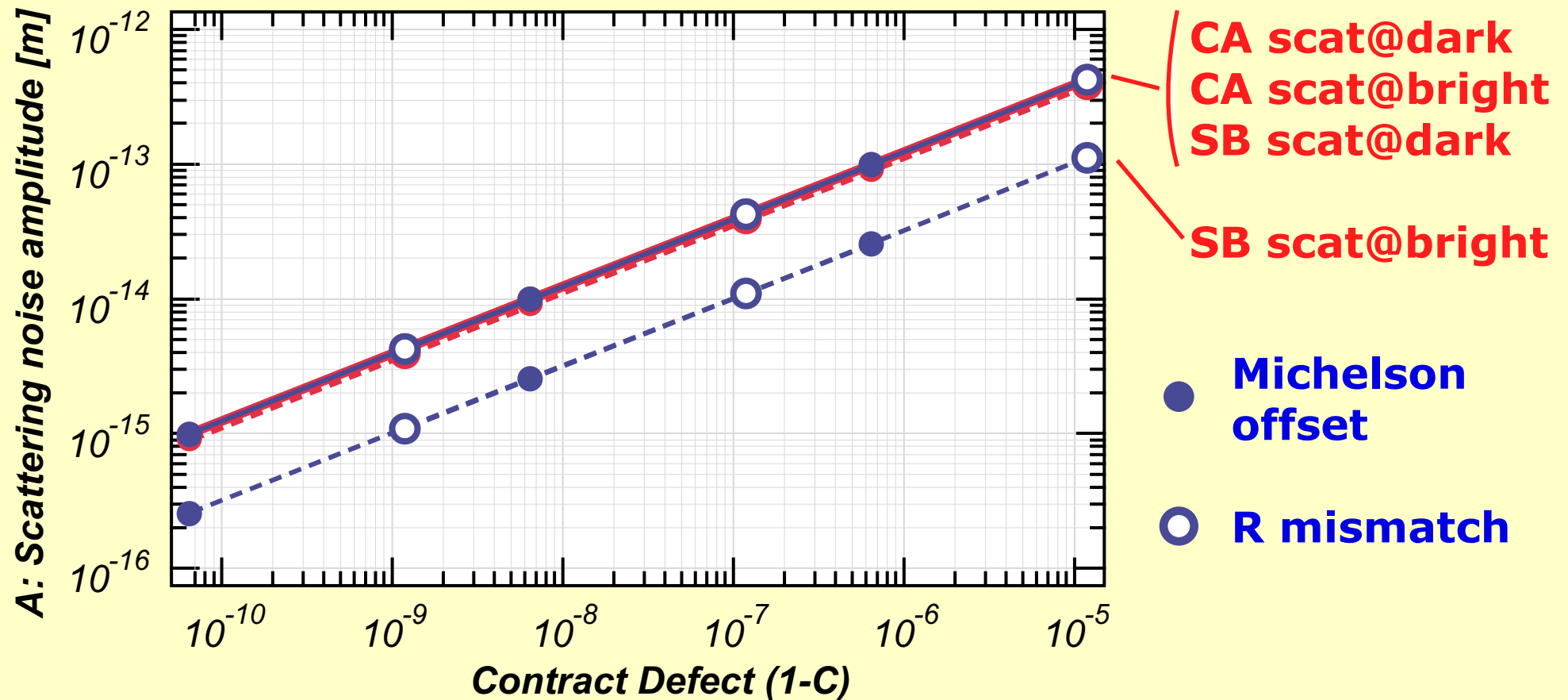
$$A = 9.0 \times 10^{-11} P_{\text{out}} [m] \quad (\text{for 1ppm scattering})$$

**Bright/Dark case: depends on how much the imperfection is**

Ideal case: no noise <= No carrier at dark, perfect common mode rejection

# MI model ~ Result

- Separate the contrib. of CA and SB



No matter what the origin of the leakage carrier is

~ Noise coupling is determined by sqrt of contrast defect  
(= by the leakage carrier field at the dark)

# ***MI model ~ Interpretation***

- Noise coupling is determined  
by the leakage carrier at the dark

Leakage carrier field  $\sqrt{P_{ca@dark}}$

## **Carrier scattering at the dark port:**

All of the injected carrier from the dark port becomes the noise

=> Noise coupling is proportional to  $\sqrt{P_{ca@dark}}$

## **Carrier scattering at the bright port:**

How much the carrier does leak to the dark port

=> proportional to  $\sqrt{P_{ca@dark}}$

## **Sideband scattering at the dark port/the bright port:**

Some amount of the scattered sidebands appears at the dark port

=> Couples with the leakage carrier

=> Proportional to  $\sqrt{P_{ca@dark}}$

# ***MI/RMI model ~ DC power***

## **RMI case:**

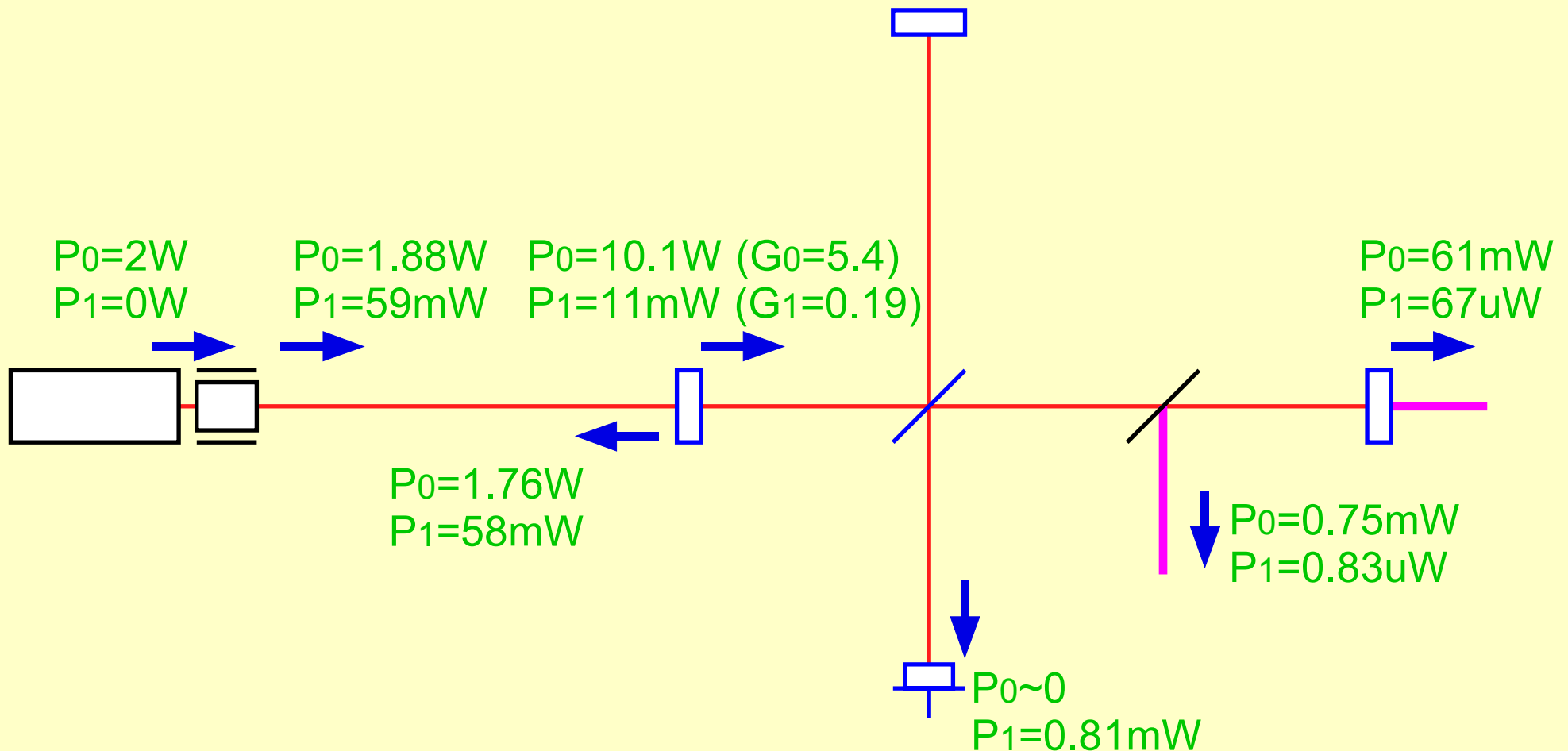
**P0:** carrier power

**P1:** sideband power

**Power consumption:**

94% is reflected to the bright port

60mWx2 (3%x2) transmitted from the arms



**MI case: Change RM with  $R=0$**

# ***MI/RMI model ~ RMI Result***

- Power recycling does not change the situation

**Power recycling increases**

**the scattered light and the signal at the same rate**

	<b>MI</b>	<b>(unit: m)</b>	<b>RMI</b>	<b>(unit: m)</b>
Arm Trans	$1.02 \times 10^{-12}$		$1.02 \times 10^{-12}$	
BS AR	$1.26 \times 10^{-14}$		$1.26 \times 10^{-14}$	
CA scat @ dark	$1.16 \times 10^{-10} \sqrt{1-C}$		$1.20 \times 10^{-10} \sqrt{1-C}$	
SB scat @ dark	$1.07 \times 10^{-10} \sqrt{1-C}$		$1.14 \times 10^{-10} \sqrt{1-C}$	
CA scat @ bright	$1.16 \times 10^{-10} \sqrt{1-C}$		$1.16 \times 10^{-10} \sqrt{1-C}$	
SB scat @ bright	$2.98 \times 10^{-11} \sqrt{1-C}$		$3.39 \times 10^{-11} \sqrt{1-C}$	

# ***MI/RMI model ~ Result Summary***

- Asymmetric scattered light

## **Constant noise coupling**

~ Independent from the interferometer condition

$$A = 9.0 \times 10^{-11} P_{\text{out}} [m] \quad (\text{for 1ppm scattering})$$

- Scattering at the dark port and the bright port

## **Dependent on the contrast defect**

$$A \sim 1 \times 10^{-10} \sqrt{1-C} [m] \quad (\text{for 1ppm scattering})$$

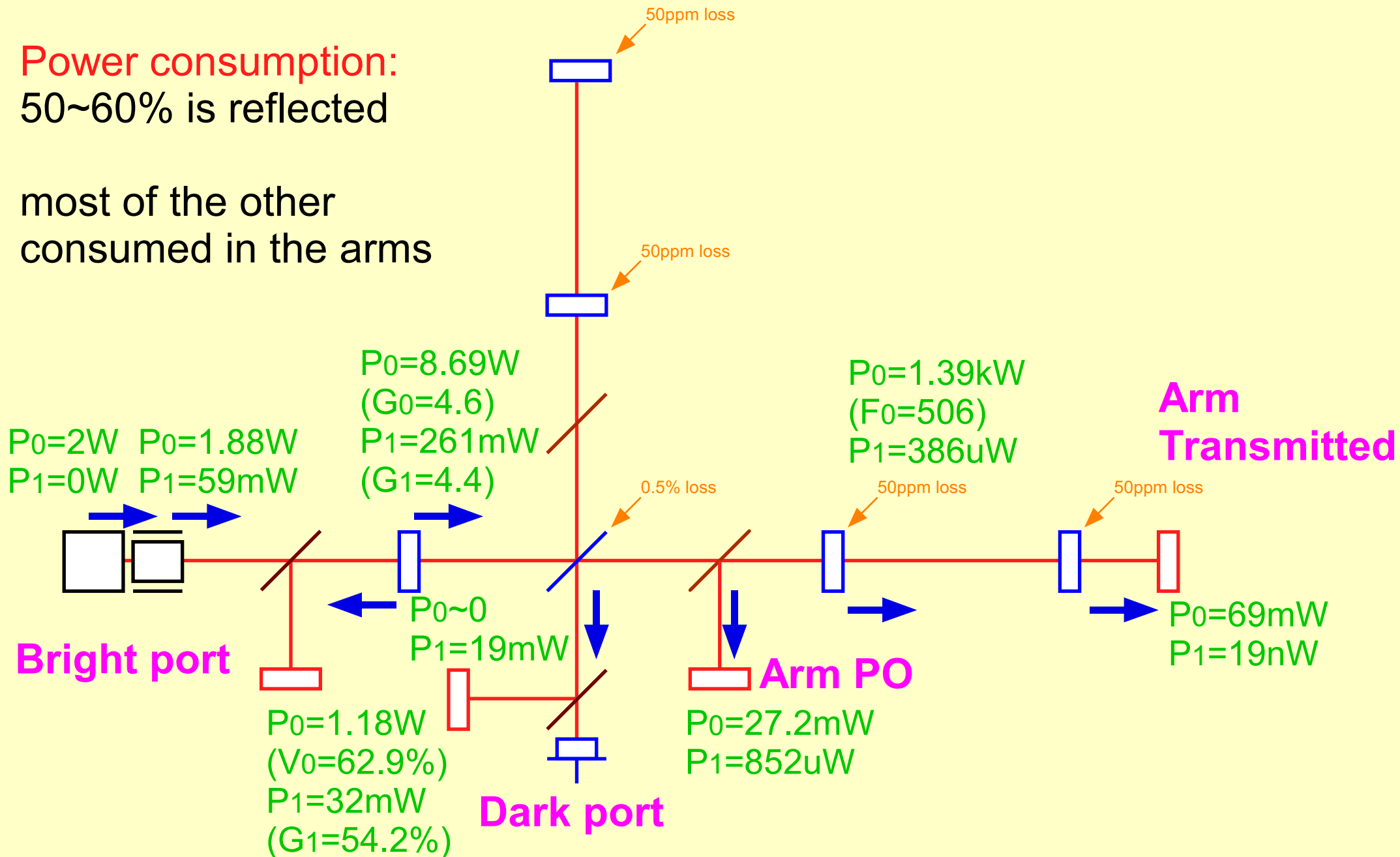
c.f. Bright port	~ Carrier of 2W	=> Same order contribution
Dark port	~ Carrier of ~0W	

- Power recycling does not change  
the scattered light noise level

# RFPMI model ~ DC light level

Power consumption:  
50~60% is reflected

most of the other  
consumed in the arms



# ***RFPMI model ~ Result***

- Even with the FP arms the noise coupling is understood as the Michelson case  
by including the signal enhancement by the FP arm  
(factor of  $N_{FP}=322$ )

	<b>MI</b>	<b>(unit: m)</b>	<b>RFPMI</b>	<b>(unit: m)</b>
FP Arm Trans			$4.23 \times 10^{-15}$	
BS AR (Arm PO)	$9.0 \times 10^{-11} P_{out}$		$9.0 \times 10^{-11} P_{out} / G_0 / N_{FP}$	
CA scat @ dark	$1.16 \times 10^{-10} \sqrt{(1-C)}$		$1.11 \times 10^{-10} \sqrt{(1-C)}$	
SB scat @ dark	$1.07 \times 10^{-10} \sqrt{(1-C)}$		$0.89 \times 10^{-10} \sqrt{(1-C)}$	
CA scat @ bright	$1.16 \times 10^{-10} \sqrt{(1-C)}$		$0.91 \times 10^{-10} \sqrt{(1-C)}$	
SB scat @ bright	$2.98 \times 10^{-11} \sqrt{(1-C)}$		$2.78 \times 10^{-11} \sqrt{(1-C)}$	

**This means:**

Scattered light noise level with MI or RMI will appear in the RFPMI sensitivity by a factor of  $1/N_{FP}$

# ***Discussion***

- Calculation shows:

**Noise from the dark port vs Noise from the bright port**

=> Comparable

**Presence of higher order modes**

=> Higher order modes increase the scattered light  
couples to the main beam

**The noise from bright port is not affected  
by the higher order modes**

=> It may be possible to estimate the imperfection level  
of the interferometer using the bright port

# **Conclusion**

- Single mode simulation for scattered light noise  
**MI/RMI/RFPMI cases are essentially the same**

=> Considering:

Recycling gain & Signal enhancement by the FP arm

**Asymmetric scattered light has the constant contrib.**

=> Independent from the interferometer condition

=> Dependent how much power appear at the optical port

**Dark port and bright port**

=> Dependent on the contrast defect

**Presence of higher order modes**

=> Increase the noise from the scattering at the dark port



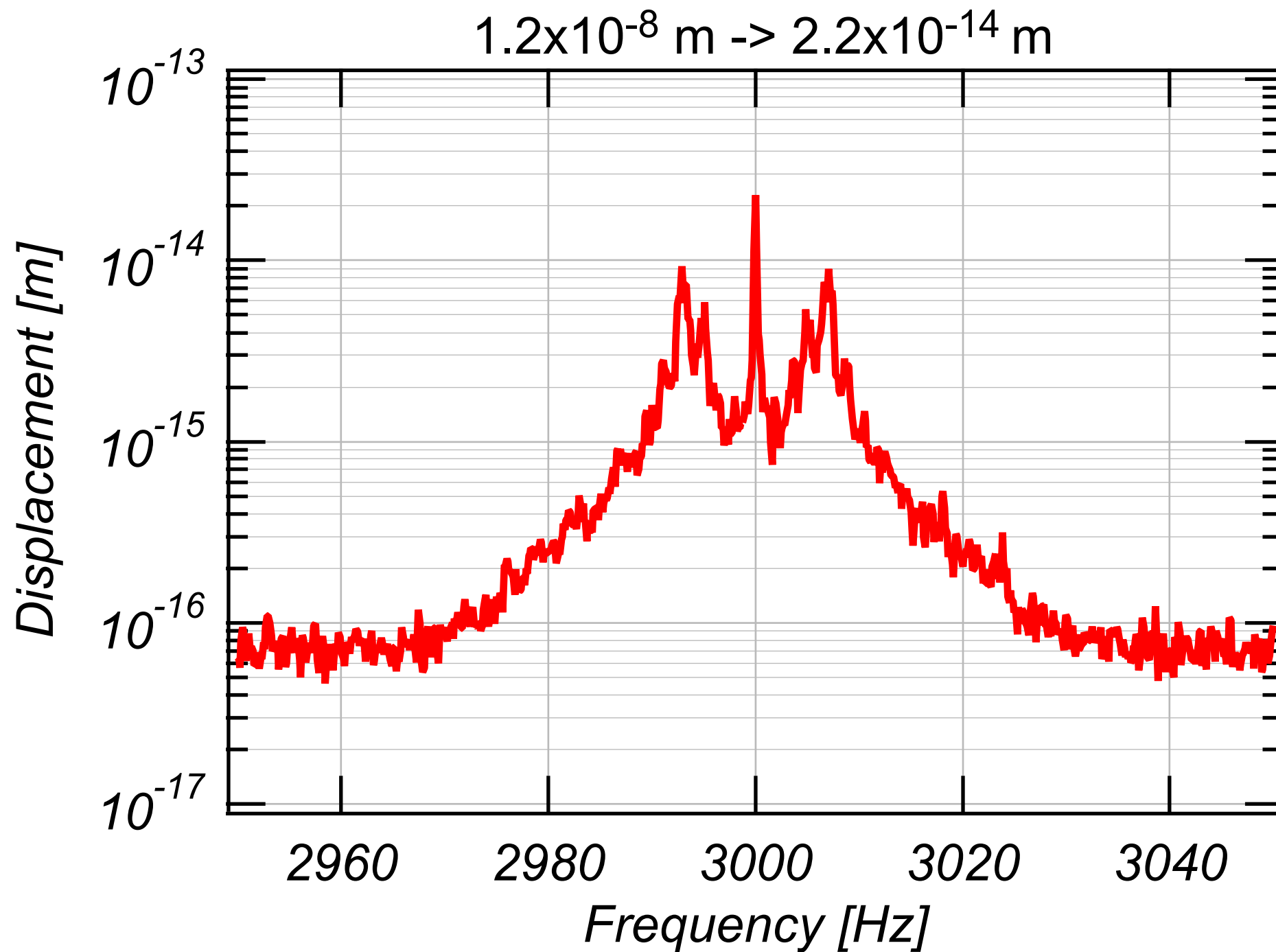
# ***Experimental investigation***

- Factors to determine the amount of the noise

1. Amount of the light power arrives  
on the scattering body.  
=> included in the calculation
2. Efficiency of effective back scattering
3. Sensitivity of the signal to the scattering  
=> included in the calculation
4. Amount of the scattering body's motion  
=> vibration measurement with an accelerometer

## ***Actuation of the optics***

- a) with a small amplitude
- b) with a large amplitude



## RMI displacement (2004/2/18)

